Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/056,005	KARINO ET AL.

Examiner

Kerri M. Dyke

Art Unit 2616

SEARCHED					
Class	Subclass	Date	Examiner		
370	229-233	10/26/2005	KMD		
	235				
	236				
370	328-329	10/28/2005	KMD		
	408				
Above	UPDATED	2/15/2006	KMD		
455	422.1	2/15/2006	KMD		
455	436	2/15/2006	KMD		
Above	Updated	5/30/2006	KMD		
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INTERFERENCE SEARCHED					
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,	DATE	EXMR
East	10/31/2005	KMD
STIC PLUS	10/27/2005	KMD
IEEE and ACM - see printout	10/28/2005	KMD
East - see printout	2/15/2006	KMD
East - see printout	5/30/2006	KMD
East - see printout	6/1/2006	KMD
Combined citation search: 2002/0194361; 2004/0095882	6/1/2006	KMD